Electronic Version v1.1 Stylesheet Version v1.1

 SUBMISSION TYPE:
 NEW ASSIGNMENT

 NATURE OF CONVEYANCE:
 ASSIGNMENT

CONVEYING PARTY DATA

Name	Execution Date	
U.S. PHILIPS CORPORATION	01/03/2008	

RECEIVING PARTY DATA

Name:	PANalytical BV
Street Address:	Lelyweg 1
City:	Almelo
State/Country:	NETHERLANDS
Postal Code:	7602 EA

PROPERTY NUMBERS Total: 11

Property Type	Number
Patent Number:	5509043
Patent Number:	5195115
Patent Number:	6108401
Patent Number:	6370490
Patent Number:	5831184
Patent Number:	6263042
Patent Number:	4903287
Patent Number:	6359968
Patent Number:	5157704
Patent Number:	5216539
Patent Number:	6233306

CORRESPONDENCE DATA

Fax Number: (914)332-0615

Correspondence will be sent via US Mail when the fax attempt is unsuccessful.

Phone: (914) 333-9642

PATENT REEL: 020468 FRAME: 0250

500457166

Email: patti.demichele@philips.com

Correspondent Name: Philips Electronics North America Corp.

Address Line 1: 345 Scarborough Road

Address Line 4: Briarcliff Manor, NEW YORK 10510

ATTORNEY DOCKET NUMBER: 8001-0057 PANALYTICAL

NAME OF SUBMITTER: Michael E. Marion

Total Attachments: 1

source=USPC_PANalytical_2008Jan03#page1.tif

PATENT REEL: 020468 FRAME: 0251

ASSIGNMENT

U.S. PHILIPS CORPORATION, a Delaware Corporation, having an office at 1251 Avenue of the Americas, New York, NY 10020, USA (hereinafter "Assignor"), in consideration of one dollar and other good and valuable consideration, the receipt of which is hereby acknowledged, hereby sells, assigns and transfers to PANalytical BV ("PANalytical"), a Private limited liability company organised under the laws of the Kingdom of Netherlands, with office at Lelyweg 1, 7602 EA Almelo, The Netherlands, (hereinafter "Assignee") all its right, title and interest in the following United States Patents (hereinafter "Patent Rights"):

Assignors ref	Title	Application nr	Grant date	Patent nr
N 014525US	ASYMMETRICAL FOUR CRYSTAL MONOCHROMATOR	08/276140	16-Apr-1996	5509043
F 090551US	X-RAY DIFFRACTOMETER FOR LARGE D VALUES	07/733925	16-Mar-1993	5195115
N 016706US	QUANTITATIVE X-RAY PHASE ANALYSIS WITHOUT STANDARDS	09/216255	22-Aug-2000	6108401
N 017471US	FAST MAXIMUM ENTROPY ALGORITHM FOR SPECTROSCOPY	09/592059	09-Apr-2002	6370490
N 015459US	SAMPLE CONTAINER FOR X-RAY ANALYSIS	08/710626	03-Nov-1998	5831184
N 017117US	NON-SEQUENTIAL ANGULAR SCAN IN GEXRF	09/406285	17-Jul-2001	6263042
D 087098US	MONOCHROMATIC X-RAY SOURCE	07/194631	20-Feb-1990	4903287
D 099017US	X-RAY TUBE WITH VAPOUR TARGET	09/501895	19-Mar-2002	6359968
D 090089US	IMPROVED MONOCHROMATIC X-RAY SOURCE	07/704241	20-Oct-1992	5157704
F 089597US	MULTILAYER X-RAY MIRROR	07/688621	01-Jun-1993	5216539
N 017132US	X-RAY TUBE WITH X-RAY OPTICAL FIBERS	09/414461	15-May-2001	6233306

owned by Assignor, provided however that Assignor does not hereby sell, assign or transfer any interest in and/or right to claim and to sue for damages resulting from past infringement of said Patent Rights.

The Assignment is made subject to Assignor retaining a royalty free, world wide, non-exclusive, irrevocable and unrestricted license under said Patent Rights and further subject to all existing rights, commitments, licenses, non-assertion agreements and the like made by Assignor, KONINKLIJKE PHILIPS ELECTRONICS N.V. and/or its affiliates under said Patent Rights and to any extensions of term and/or renewals thereof.

Assignor covenants and agrees that it will, upon request, execute and deliver to Assignee or its legal representatives any and all papers, instruments and/or affidavits required to apply for, obtain, maintain, issue, and/or enforce said Patent Rights which may be necessary to carry out the purposes hereof.

EXECUTED for and on behalf of U.S. PHILIPS CORPORATION

Date

PATENT REEL: 020468 FRAME: 0252

RECORDED: 02/06/2008